

<b>Notice of References Cited</b>	Application/Control No. 10/526,917		Applicant(s)/Patent Under Reexamination FUKUDA ET AL.	
	Examiner JOHN J. FIGUEROA		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,360,859	11-1994	Ogawa et al.	524/437
*	B	US-5,250,279	10-1993	Preston et al.	423/432
*	C	US-5,141,980	08-1992	Ranceze et al.	524/399
*	D	US-4,427,816	01-1984	Aoki et al.	524/357
*	E	US-4,351,814	09-1982	Miyata et al.	423/306
*	F	US-4,299,759	11-1981	Miyata et al.	524/424
*	G	US-3,650,704	03-1972	Kumura et al.	423/415.1
*	H	US-3,539,306	11-1970	YASUTOMI KIMIAKI; et. al.	423/432
*	I	US-4,729,854	03-1988	Miyata et al.	252/609
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/05304 a1	02-2000	PCT	PAPAZOGLU et al.	-----
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.